TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSIII)

# **TPC6104**

# Notebook PC Applications Portable Equipment Applications

• Low drain-source ON resistance: RDS (ON) = 33 m $\Omega$  (typ.)

• High forward transfer admittance:  $|Y_{fs}| = 12 S \text{ (typ.)}$ 

• Low leakage current:  $IDSS = -10 \mu A (max) (VDS = -20 V)$ 

• Enhancement mode:  $V_{th}$  = -0.5 to -1.2 V ( $V_{DS}$  = -10 V,  $I_D$  = -200  $\mu A$ )

#### Maximum Ratings (Ta = 25°C)

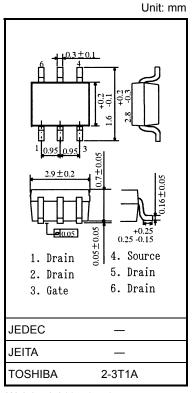
Character	istics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	-20	V	
Drain-gate voltage (R	$GS = 20 \text{ k}\Omega$ )	$V_{DGR}$	-20	V	
Gate-source voltage		V <sub>GSS</sub>	±8	V	
Drain current	DC (Note 1)	I <sub>D</sub>	-5.5	А	
Dialii Cuirent	Pulse (Note 1)	I <sub>DP</sub>	-22		
Drain power dissipation	on (t = 5 s) (Note 2a)	$P_{D}$	2.2	W	
Drain power dissipation	on (t = 5 s) (Note 2b)	P <sub>D</sub>	0.7	W	
Single pulse avalanch	e energy (Note 3)	E <sub>AS</sub>	4.9	mJ	
Avalanche current		I <sub>AR</sub>	-2.75	Α	
Repetitive avalanche	energy (Note 4)	E <sub>AR</sub>	0.22	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	ange	T <sub>stg</sub>	-55~150	°C	

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 5 s) (Note 2a)	R <sub>th (ch-a)</sub>	56.8	°C/W
Thermal resistance, channel to ambient (t = 5 s) (Note 2b)	R <sub>th (ch-a)</sub>	178.5	°C/W

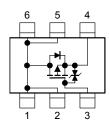
Note: Note 1, Note 2, Note 3, Note 4 and Note 5: See the next page.

This transistor is an electrostatic-sensitive device. Please handle with caution.



Weight: 0.011 g (typ.)

#### **Circuit Configuration**



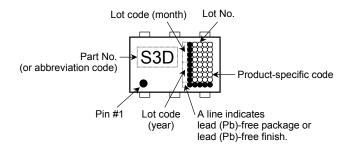
## Electrical Characteristics (Ta = 25°C)

Ch	Characteristics		Test Condition	Min	Тур.	Max	Unit	
Gate leakage cui	rrent	I <sub>GSS</sub>	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА	
Drain cut-off curr	ent	I <sub>DSS</sub>	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$		_	-10	μА	
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = -10$ mA, $V_{GS} = 0$ V	-20			٧	
Brain-30dice bre	ardown voltage	V (BR) DSX	$I_D = -10 \text{ mA}, V_{GS} = 8 \text{ V}$	-12				
Gate threshold v	oltage	$V_{th}$	$V_{DS} = -10 \ V, \ I_D = -200 \ \mu A$	-0.5	_	-1.2	V	
		R <sub>DS (ON)</sub>	$V_{GS} = -1.8 \text{ V}, I_D = -1.4 \text{ A}$		78	120		
Drain-source ON	resistance	R <sub>DS</sub> (ON)	$V_{GS} = -2.5 \text{ V}, I_D = -2.8 \text{ A}$	_	49	60	mΩ	
		R <sub>DS</sub> (ON)	$V_{GS} = -4.5 \text{ V}, I_D = -2.8 \text{ A}$	_	33	40		
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = -10 \text{ V}, I_D = -2.8 \text{ A}$	6	12	_	S	
Input capacitance		C <sub>iss</sub>		_	1430	_	pF	
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	200	_		
Output capacitance		C <sub>oss</sub>		_	240	_		
Switching time	Rise time	t <sub>r</sub>	V <sub>GS</sub> 0 V   I <sub>D</sub> = -2.8 A   O V <sub>OUT</sub>   C	_	8.5	_		
	Turn-on time	t <sub>on</sub>		_	15	_		
	Fall time	t <sub>f</sub>	7.7.7.00 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1	_	20	_	ns	
	Turn-off time	t <sub>off</sub>	$V_{DD} \simeq -10 \text{ V}$ Duty $\leq 1\%$ , $t_W = 10 \mu\text{s}$	_	66	_		
Total gate charge (gate-source plus gate-drain)		Qg	V <sub>DD</sub> ≃ −16 V, V <sub>GS</sub> = −5 V.	_	19	_		
Gate-source charge		Q <sub>gs</sub>	$I_D = -5.5 \text{ A}$	_	14	_	nC	
Gate-drain ("mille	er") charge	Q <sub>gd</sub>		_	5	_		

## Source-Drain Ratings and Characteristics (Ta = 25°C)

Charact	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>	_	_	_	-22	Α
Forward voltage	(diode)	V <sub>DSF</sub>	$I_{DR} = -5.5 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	1.2	V

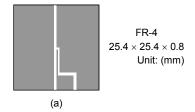
#### Marking (Note 5)

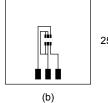


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a) (t = 5 s)

(b) Device mounted on a glass-epoxy board (b) (t = 5 s)





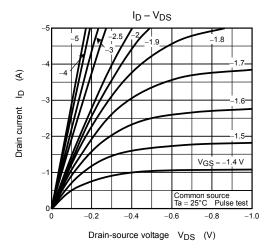
 $\begin{aligned} & \text{FR-4} \\ 25.4 \times 25.4 \times 0.8 \\ & \text{Unit: (mm)} \end{aligned}$ 

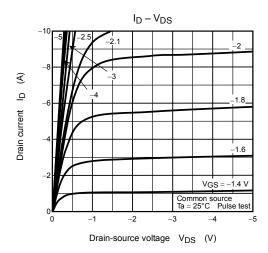
Note 3:  $V_{DD} = -16 \text{ V}$ ,  $T_{ch} = 25^{\circ}\text{C}$  (initial), L = 0.5 mH,  $R_G = 25 \Omega$ ,  $I_{AR} = -2.75 \text{ A}$ 

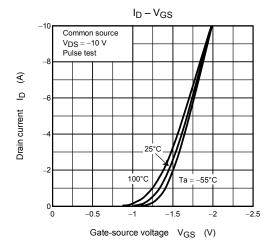
Note 4: Repetitive rating;:pulse width limited by maximum channel temperature

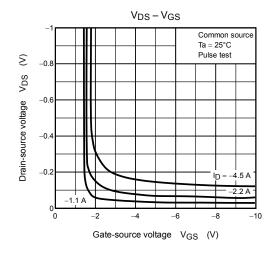
Note 5: • on lower left of the marking indicates Pin 1.

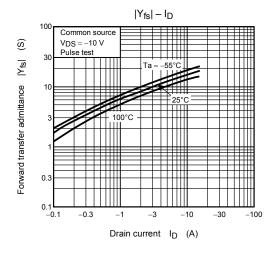
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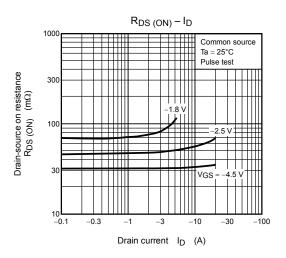


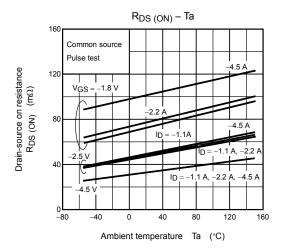


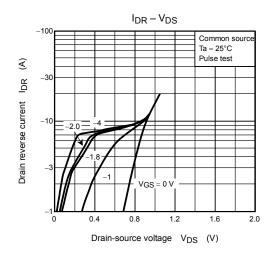


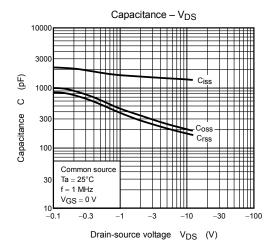


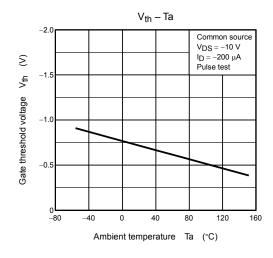


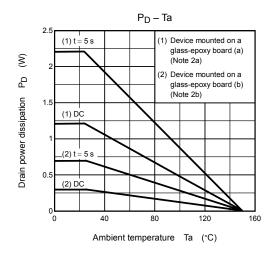


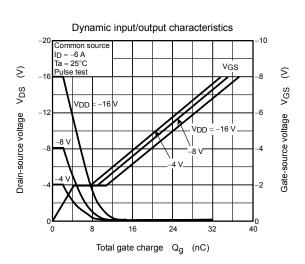




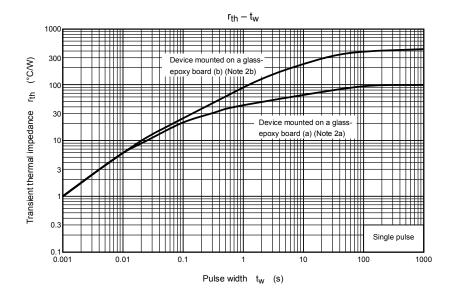


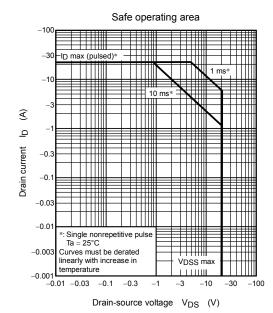






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